

SAK-5286

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Masamichi ISHIHARA, et al

Serial No.: not yet assigned

Filed: April 28, 2006

For: SEMICONDUCTOR DEVICE AND PROCESS FOR FABRICATING
THE SAME

Group: not yet assigned

Examiner: not yet assigned

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 CFR §1.97 & 1.98**

MS Amendment

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

April 28, 2006

Sir:

In the matter of the above-identified application, applicants are submitting herewith a copy of a communication from a foreign patent office in a counterpart foreign application and copies of the documents listed in the attached form equivalent to Form PTO-1449 for the Examiner's consideration.

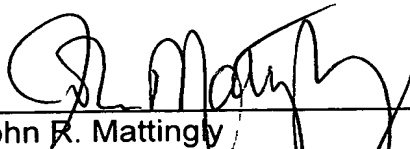
This information disclosure statement is being submitted with the new application.

Although some of the documents listed on the attached form equivalent to Form PTO-1449 are not in the English language, the requirement of 37 CFR §1.98(a)(3) for a concise explanation of the relevance is satisfied by the discussion of these documents in the specification.

It is respectfully requested that this information disclosure statement be considered by the Examiner.

Please charge any shortage in the fees due in connection with the filing of this paper, including extension of time fees, to the deposit account of MATTINGLY, STANGER, MALUR & BRUNDIDGE, P.C., Deposit Account No. 50-1417 (SAK-5286) please credit any excess fees to such deposit account.

Respectfully submitted,



JRM/nac
(703) 684-1120

John R. Mattingly
Registration No. 30,298
MATTINGLY, STANGER, MALUR & BRUNDIDGE, P.C.

Sheet 1 of 1

Form PTO- 1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DKT. NO. SAK-5286	SERIAL NO. NOT YET ASSIGNED 10/577863
		APPLICANT Masamichi ISHIHARA, et al	
		FILING DATE April 28, 2006	GROUP Not Yet Assigned

**INFORMATION DISCLOSURE
STATEMENT
BY APPLICANT**

(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date
AA						
AB						
AC						
AD						
AE						
AF						
AG						
AH						
AI						
AJ						
AK						
AL						

FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Abstract	
						Yes	No
AM	10-223833	08/98	JP			X	
AN	2003-110084	4/03	JP			X	
AO	10-027824	01/98	JP			X	
AP	2003-309221	10/03	JP			X	
AQ	2003-046057	02/03	JP			x	
AR	2001-250913	09/01	JP			X	
AS							
AT							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

AU	"The Institute of Electrical Engineers of Japan, Research Reports of Materials Research Society, Vol. EFM-02-6, No. 1-8, P.31-35.
AV	Journal of the Surface Finishing Society of Japan, Vol. 52, No. 7, 2001, P.479-483.
AW	
AX	
AY	
AZ	
Examiner	Date Considered